
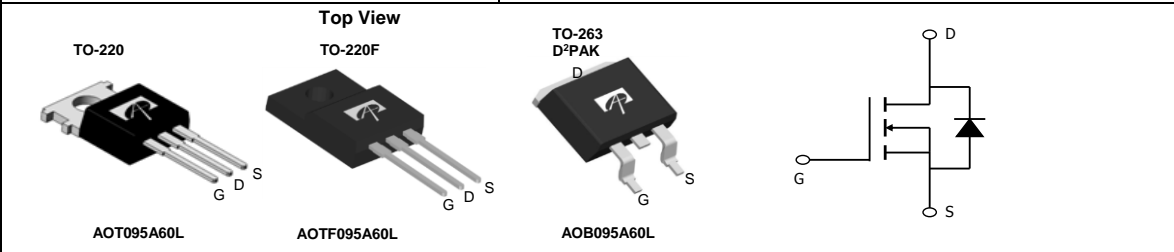


<p>General Description</p> <ul style="list-style-type: none"> Proprietary αMOS5™ technology Low $R_{DS(ON)}$ Optimized switching parameters for better EMI performance Enhanced body diode for robustness and fast reverse recovery <p>Applications</p> <ul style="list-style-type: none"> SMPS with PFC, Flyback and LLC topologies Micro inverter with DC/AC inverter topology 	<p>Product Summary</p> <table border="0"> <tr> <td>$V_{DS} @ T_{j,max}$</td> <td>700V</td> </tr> <tr> <td>I_{DM}</td> <td>152A</td> </tr> <tr> <td>$R_{DS(ON),max}$</td> <td>< 0.095Ω</td> </tr> <tr> <td>$Q_{g,typ}$</td> <td>78nC</td> </tr> <tr> <td>$E_{oss} @ 400V$</td> <td>7.8μJ</td> </tr> </table> <p>100% UIS Tested 100% R_g Tested</p> 	$V_{DS} @ T_{j,max}$	700V	I_{DM}	152A	$R_{DS(ON),max}$	< 0.095 Ω	$Q_{g,typ}$	78nC	$E_{oss} @ 400V$	7.8 μ J
$V_{DS} @ T_{j,max}$	700V										
I_{DM}	152A										
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$Q_{g,typ}$	78nC										
$E_{oss} @ 400V$	7.8 μ J										



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOTF095A60L	TO-220F Green	Tube	1000
AOT095A60L	TO-220 Green	Tube	1000
AOB095A60L	TO-263 Green	Tape&Reel	800

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	AOT(B)095A60L	AOTF095A60L	Units
Drain-Source Voltage	V_{DS}	600		V
Gate-Source Voltage	V_{GS}	± 20		V
Gate-Source Voltage (dynamic) AC($f > 1\text{Hz}$)	V_{GS}	± 30		V
Continuous Drain Current	I_D	$T_C=25^\circ\text{C}$	38	38*
		$T_C=100^\circ\text{C}$	24	24*
Pulsed Drain Current ^c	I_{DM}	152		A
Avalanche Current ^c	I_{AR}	11		A
Repetitive avalanche energy ^c	E_{AR}	60		mJ
Single pulsed avalanche energy ^g	E_{AS}	480		mJ
MOSFET dv/dt ruggedness	dv/dt	100		V/ns
Diode reverse recovery $V_{DS}=0$ to 400V, $I_F \leq 20\text{A}$, $T_j=25^\circ\text{C}$	dv/dt	20		V/ns
	di/dt	500		A/us
Power Dissipation ^b	P_D	$T_C=25^\circ\text{C}$	378	41
		Derate above 25 $^\circ\text{C}$	3.0	0.3
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150		$^\circ\text{C}$
Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds	T_L	300		$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	AOT(B)095A60L	AOTF095A60L	Units
Maximum Junction-to-Ambient ^{A,D}	$R_{\theta JA}$	65	65	$^\circ\text{C/W}$
Maximum Case-to-sink ^A	$R_{\theta CS}$	0.5	--	$^\circ\text{C/W}$
Maximum Junction-to-Case	$R_{\theta JC}$	0.33	3	$^\circ\text{C/W}$

* Drain current limited by maximum junction temperature.

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V, T _J =25°C	600			V
		I _D =250μA, V _{GS} =0V, T _J =150°C		700		
BV _{DSS} /ΔT _J	Breakdown Voltage Temperature Coefficient	I _D =250μA, V _{GS} =0V		0.51		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =600V, V _{GS} =0V			1	μA
		V _{DS} =480V, T _J =125°C			10	
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =5V, I _D =250μA	2.4	3	3.6	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =19A		0.082	0.095	Ω
g _{FS}	Forward Transconductance	V _{DS} =10V, I _D =19A		25		S
V _{SD}	Diode Forward Voltage	I _S =19A, V _{GS} =0V		0.86	1.2	V
I _S	Maximum Body-Diode Continuous Current				38	A
I _{SM}	Maximum Body-Diode Pulsed Current ^C				152	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =100V, f=1MHz		4010		pF
C _{oss}	Output Capacitance			105		pF
C _{o(er)}	Effective output capacitance, energy related ^H	V _{GS} =0V, V _{DS} =0 to 480V, f=1MHz		90		pF
C _{o(tr)}	Effective output capacitance, time related ^I			390		pF
C _{rss}	Reverse Transfer Capacitance	V _{GS} =0V, V _{DS} =100V, f=1MHz		1.2		pF
R _g	Gate resistance	f=1MHz		5.5		Ω
SWITCHING PARAMETERS						
Q _g	Total Gate Charge	V _{GS} =10V, V _{DS} =480V, I _D =19A		78		nC
Q _{gs}	Gate Source Charge			28		nC
Q _{gd}	Gate Drain Charge			24		nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =10V, V _{DS} =400V, I _D =19A, R _G =5Ω		48		ns
t _r	Turn-On Rise Time			50		ns
t _{D(off)}	Turn-Off DelayTime			99		ns
t _f	Turn-Off Fall Time			33		ns
t _{rr}	Body Diode Reverse Recovery Time			444		ns
I _{rm}	Peak Reverse Recovery Current	I _F =19A, di/dt=100A/μs, V _{DS} =400V		36		A
Q _{rr}	Body Diode Reverse Recovery Charge			11.5		μC

A. The value of R_{θJA} is measured with the device in a still air environment with T_A=25° C.

B. The power dissipation P_D is based on T_{J(MAX)}=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initial T_J=25° C.

D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

G. L=60mH, I_{AS}=4 A, R_G=25Ω, Starting T_J=25° C.

H. C_{o(er)} is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{(BR)DSS}.

I. C_{o(tr)} is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{(BR)DSS}.

APPLICATIONS OR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN,FUNCTIONS AND RELIABILITY WITHOUT NOTICE.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

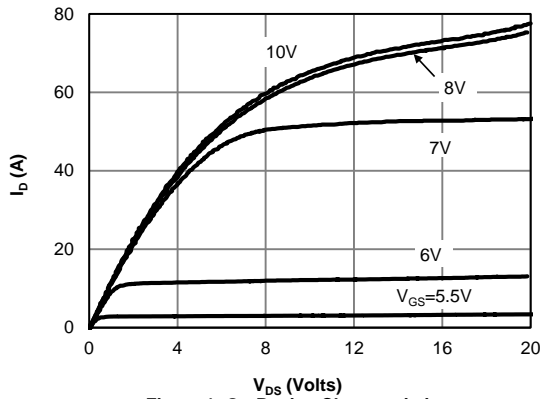


Figure 1: On-Region Characteristics

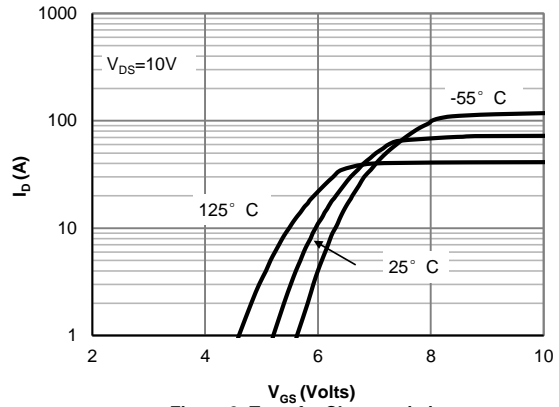


Figure 2: Transfer Characteristics

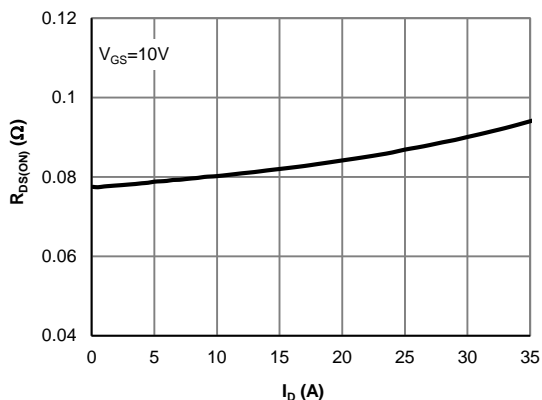


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

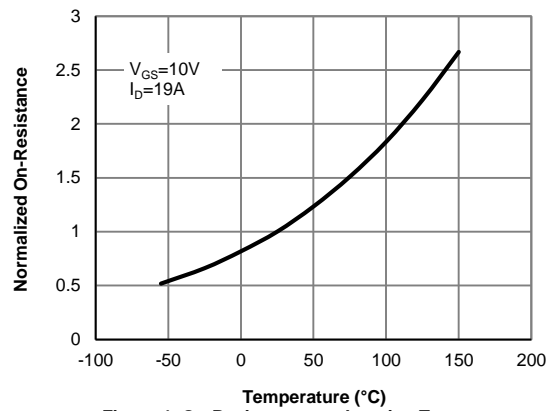


Figure 4: On-Resistance vs. Junction Temperature

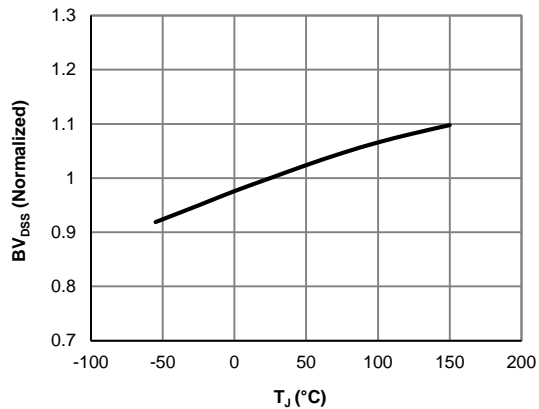


Figure 5: Break Down vs. Junction Temperature

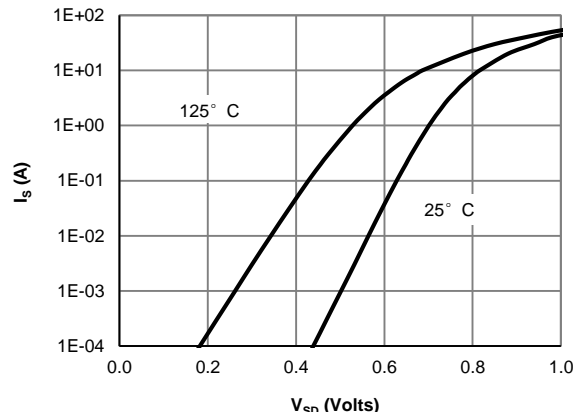


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

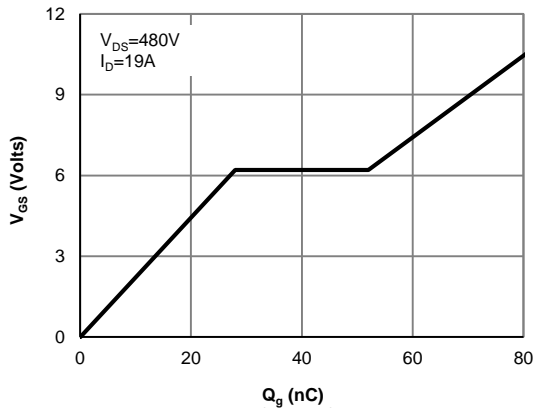


Figure 7: Gate-Charge Characteristics

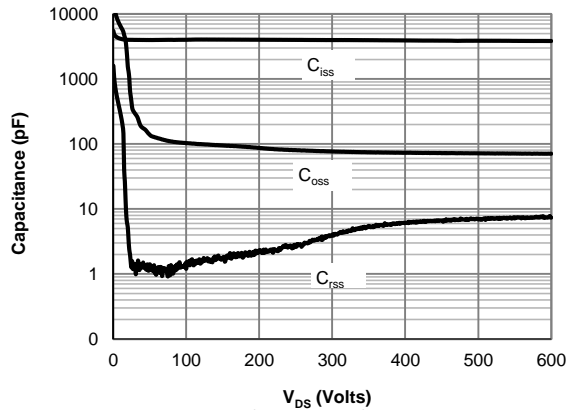


Figure 8: Capacitance Characteristics

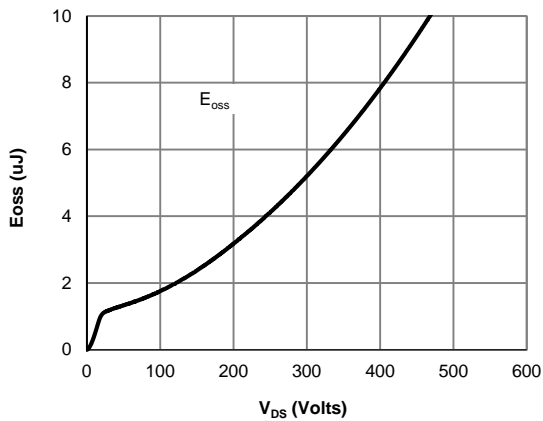


Figure 9: Coss stored Energy

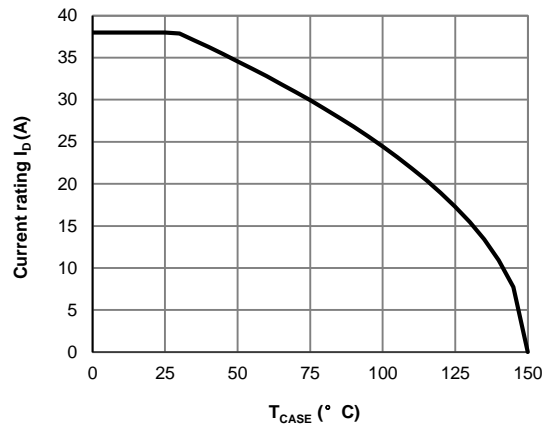


Figure 10: Current De-rating (Note F)

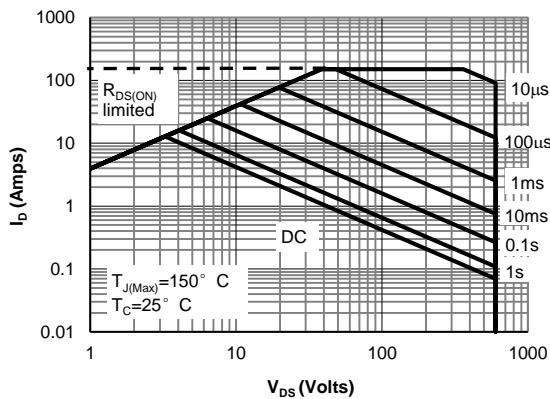


Figure 11: Maximum Forward Biased Safe Operating Area for AOTF095A60L (Note F)

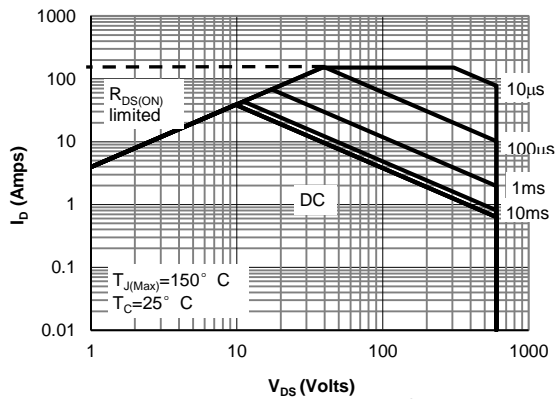


Figure 12: Maximum Forward Biased Safe Operating Area for AOT(B)095A60L (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

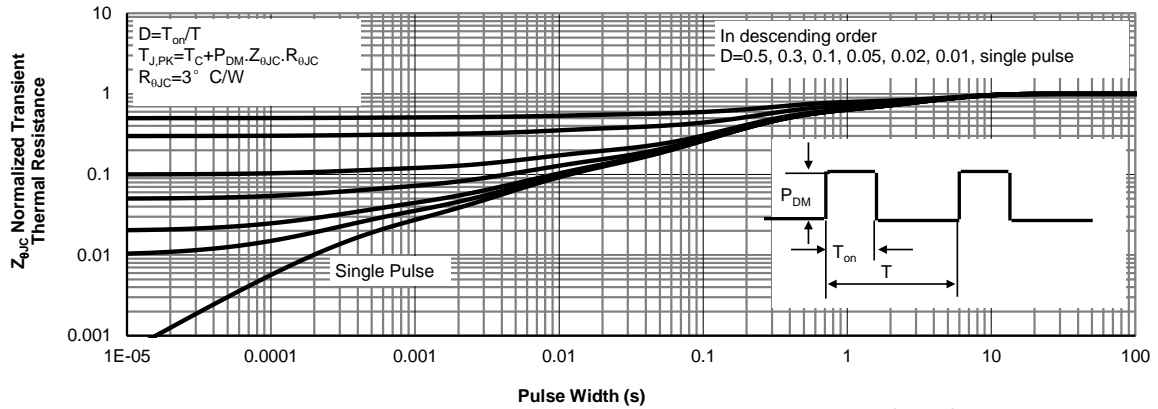


Figure 13: Normalized Maximum Transient Thermal Impedance for AOTF095A60L (Note F)

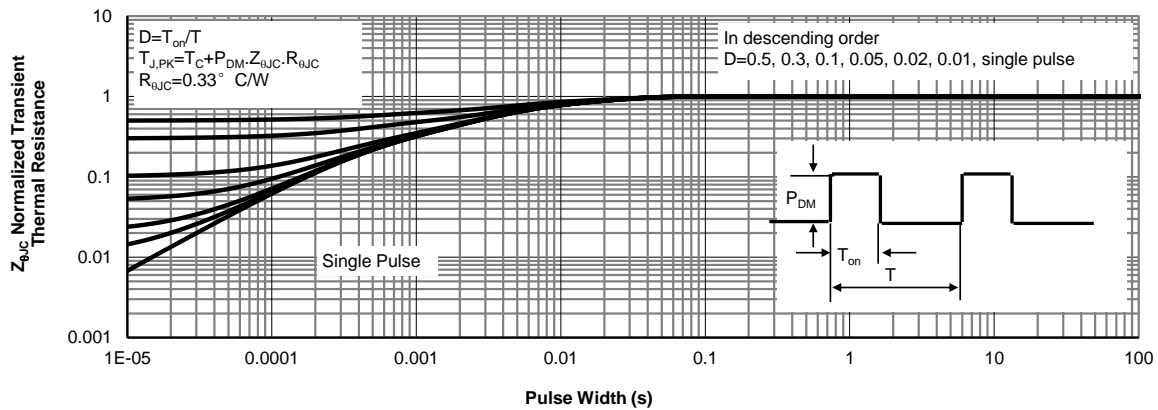
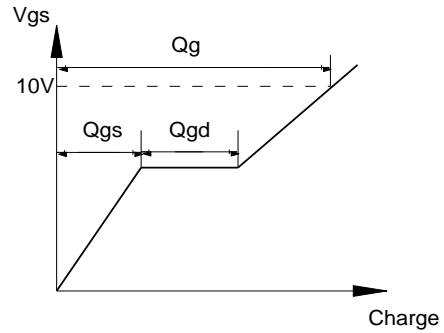
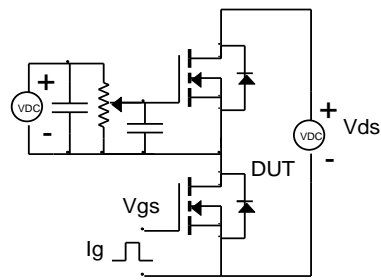
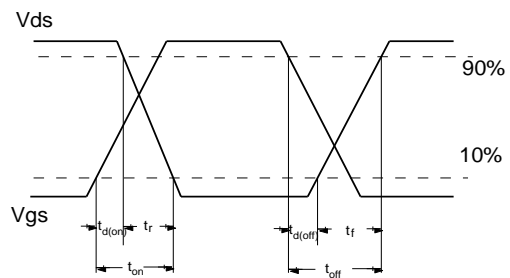
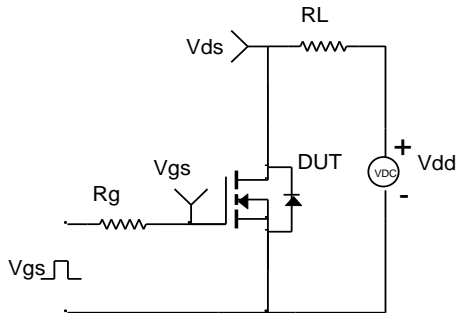


Figure 14: Normalized Maximum Transient Thermal Impedance for AOT(B)095A60L (Note F)

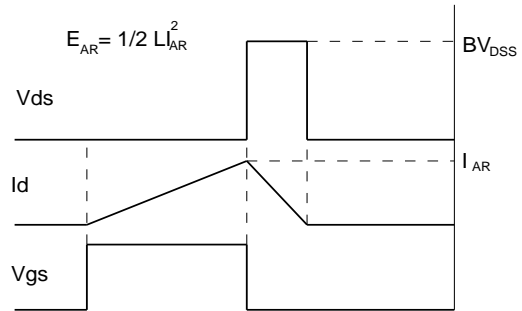
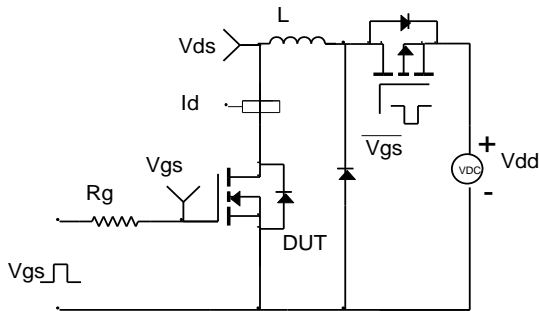
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

